

N-Channel Enhancement Mode Field Effect Transistor

General Description

These miniature surface mount MOSFETs utilize High Cell Density process. Low  $r_{DS(on)}$  assures minimal power loss and conserves energy, making this device ideal for use in power management circuitry. Typical applications are DC-DC converters, power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

Features

- $R_{DS(ON)} < 25m\Omega @ V_{GS}=4.5V$
- $R_{DS(ON)} < 35m\Omega @ V_{GS}=2.5V$
- SOT-23 Package

Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	20	V
$V_{GS}$	Gate-Source Voltage	$\pm 8$	V
$I_D @ T_C=25^\circ C$	Continuous Drain Current	6	A
$I_{DM}$	Pulsed Drain Current	18	A
$P_D @ T_C=25^\circ C$	Total Power Dissipation	1.25	W
$T_{STG}$	Storage Temperature Range	-55 to 150	$^\circ C$
$T_J$	Operating Junction Temperature Range	-55 to 150	$^\circ C$

Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-ambient	---	100	$^\circ C/W$

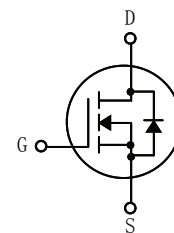
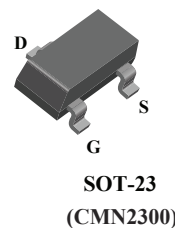
Product Summary

BVDSS	$R_{DS(ON)}$	ID
20V	25m $\Omega$	6A

Applications

- DC-DC converters
- Power Management in Notebook Computer
- Portable Equipment and Battery Powered Systems

SOT-23 Pin Configuration



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Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	20	---	---	V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =4.5V, I <sub>D</sub> =5.6A	---	---	25	mΩ
		V <sub>GS</sub> =2.5V, I <sub>D</sub> =4A	---	---	35	
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	0.45	---	1.2	V
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =16V, V <sub>GS</sub> =0V	---	---	1	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> =±8V, V <sub>DS</sub> =0V	---	---	±100	nA
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =4A	---	18	---	S
Q <sub>g</sub>	Total Gate Charge	I <sub>D</sub> =4A V <sub>DS</sub> =10V V <sub>GS</sub> =4.5V	---	9.0	---	nC
Q <sub>gs</sub>	Gate-Source Charge		---	1.8	---	
Q <sub>gd</sub>	Gate-Drain Charge		---	4.2	---	
T <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DS</sub> =10V, I <sub>D</sub> =3.5A, R <sub>G</sub> =10 Ω	---	---	20	ns
T <sub>d(off)</sub>	Turn-Off Delay Time		---	---	60	
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =10V, V <sub>GS</sub> =0V, f=1MHz	---	---	650	pF
C <sub>oss</sub>	Output Capacitance		---	---	150	
C <sub>rss</sub>	Reverse Transfer Capacitance		---	---	---	

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> =0.75A	---	---	1.3	V